

Notice of References Cited	Application/Control No. 10/574,620		Applicant(s)/Patent Under Reexamination KIRENKO, IHOR	
	Examiner Jean B. Corrielus		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,042,946	05-2006	Turaga et al.	375/240.19
*	B	US-7,526,025	04-2009	Turaga et al.	375/240.12
*	C	US-7,321,625	01-2008	Zhang et al.	375/240.11
*	D	US-2003/0202599	10-2003	Turaga et al.	375/240.19
*	E	US-7,292,635	11-2007	Yim et al.	375/240.16
*	F	US-2007/0031052	02-2007	Turaga et al.	382/240
*	G	US-2005/0047509	03-2005	Lee et al.	375/240.19
*	H	US-2003/0133500	07-2003	Auwers et al.	375/240.11
*	I	US-6,983,021	01-2006	Pesquet-Popescu et al.	375/240.16
*	J	US-7,680,190	03-2010	Xu et al.	375/240.19
*	K	US-7,675,976	03-2010	Xu et al.	375/240.19
*	L	US-7,042,946	05-2006	Turaga et al.	375/240.19
*	M	US-6,795,504	09-2004	Xu et al.	375/240.19

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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